

An introduction to modelling interferometric data.

Euro Summer School
Observation and Data reduction with the Very Large Telescope Interferometer
4–16 June 2006, Goutelas (France)

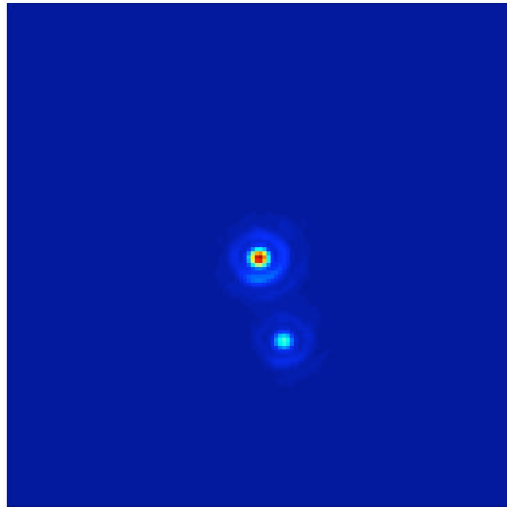
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1-Laboratoire d'Astrophysique de Grenoble

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June 5th 2006

Imaging and visibilities



FT & deconvolve

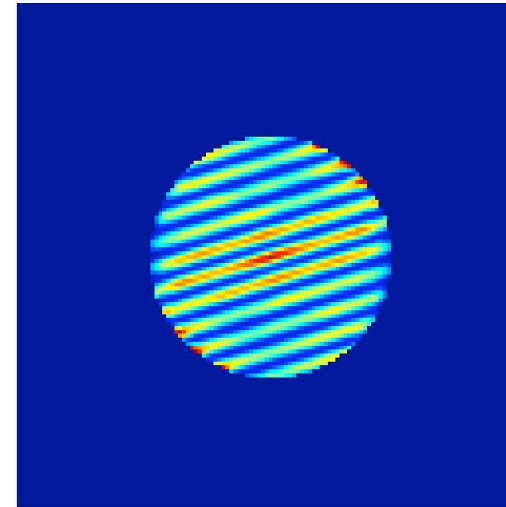


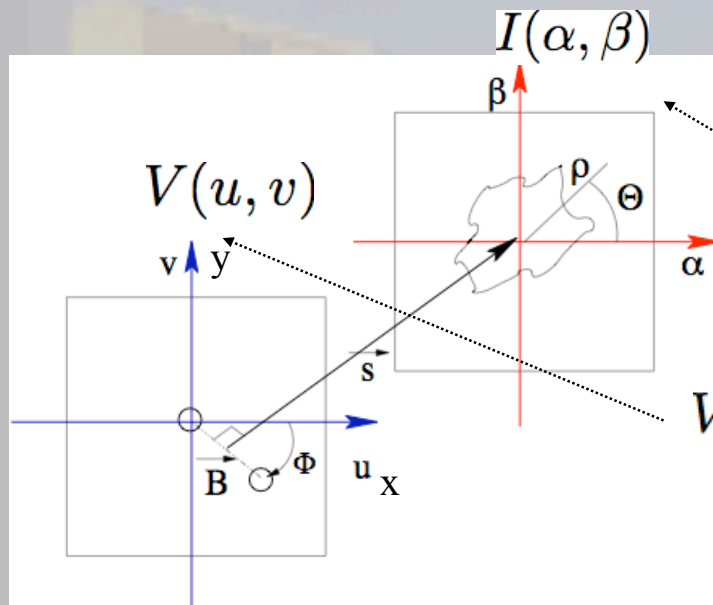
Image : $I(x,y)=O*PSF$

$V(u,v)^2$ & cut-off frequency at D/λ

Example : resolved binary star at Canada-France-Hawaii Telescope

Measuring visibilities with an interferometer

Practical application of the Van-Cittert Zernike theorem



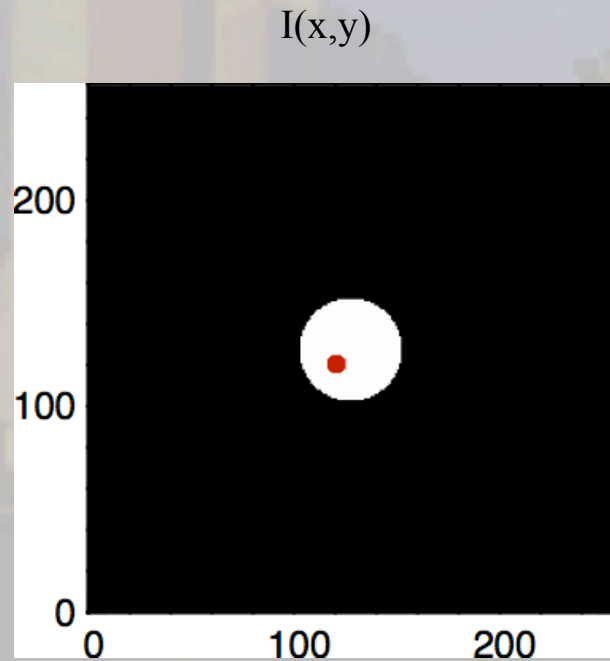
The VCZ theorem links the intensity distribution of an object in the plane of the sky (in the far field) to the complex visibility measured in the array plane.

$$V(u, v) = \frac{\iint I(\alpha, \beta) \exp^{-2i\pi(\alpha u + \beta v)} d\alpha d\beta}{\iint I(\alpha, \beta) d\alpha d\beta}$$

This relation is a Fourier transform. Spatial frequency coordinates $u=B_x/\lambda$, $v=B_y/\lambda$ where B_x and B_y stand for projected baseline coordinates on the x, y axes of telescopes

Measuring visibilities with an interferometer

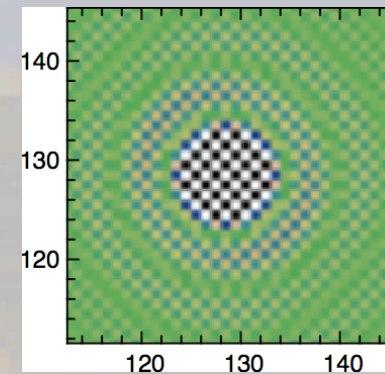
The visibility space



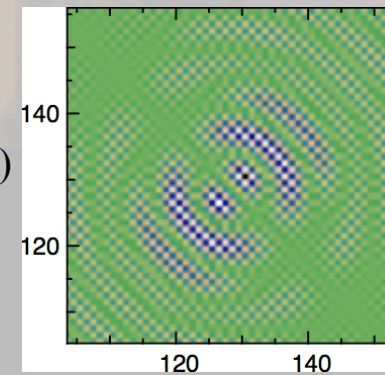
FT



Real($V(u,v)$)

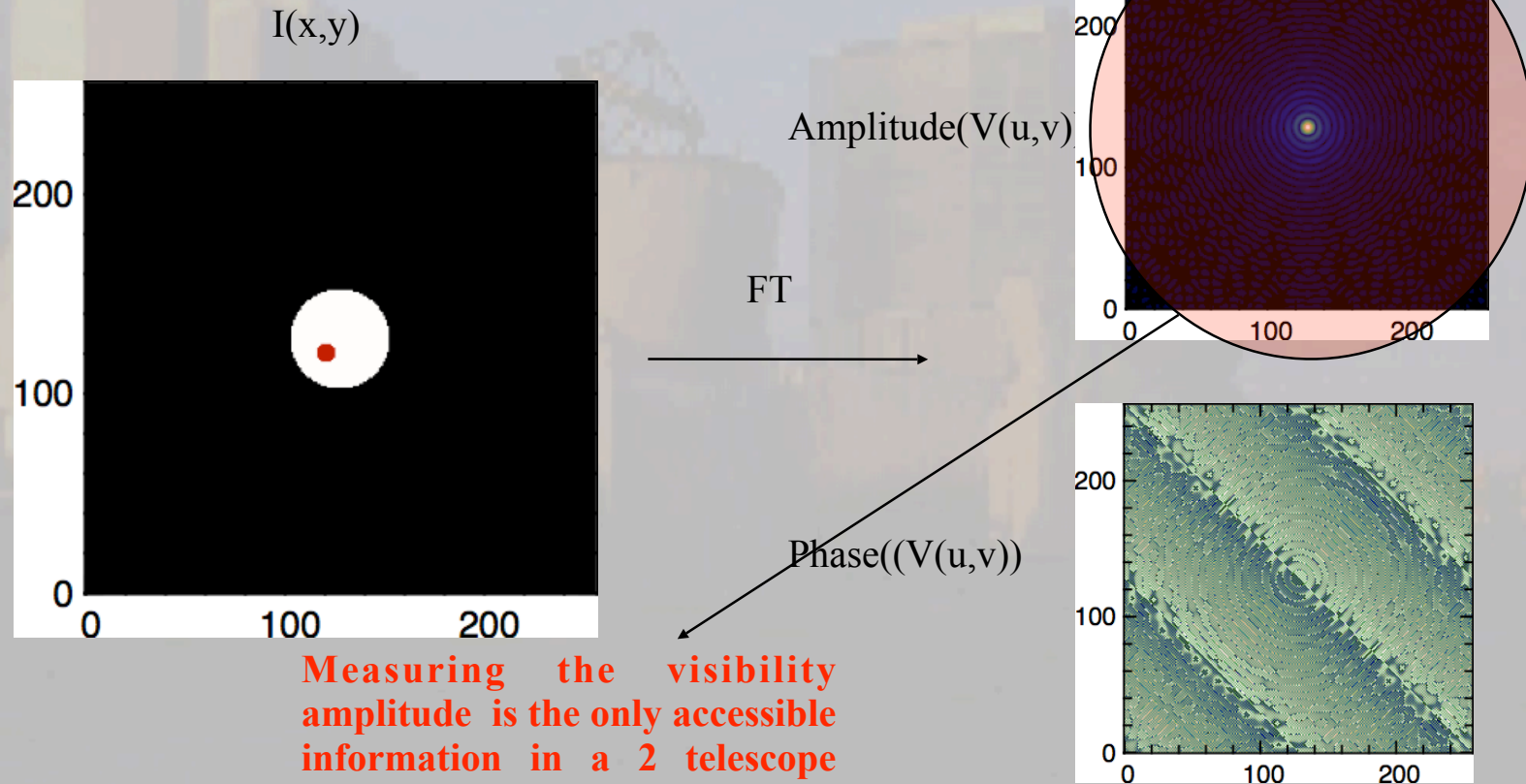


Imaginary($V(u,v)$)



Measuring visibilities with an interferometer

The visibility space

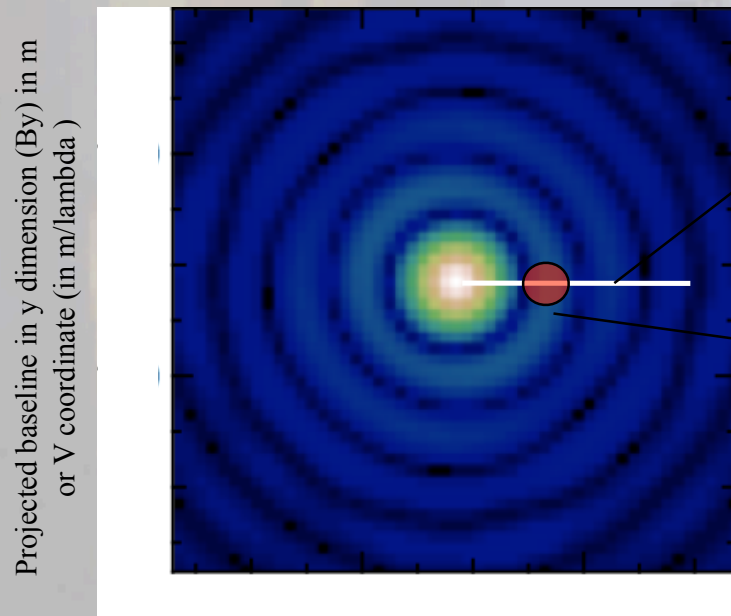


Measuring the visibility amplitude is the only accessible information in a 2 telescope interferometer (unless you have an external reference (star) or internal (continuum/line))

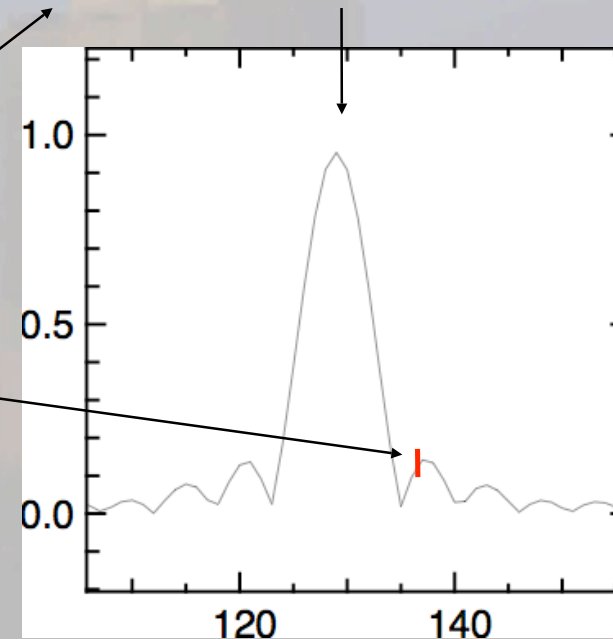
Measuring visibilities with an interferometer

The visibility space

Amplitude $V(u,v)$ (visibility of the fringe)



A cut in the visibility curve

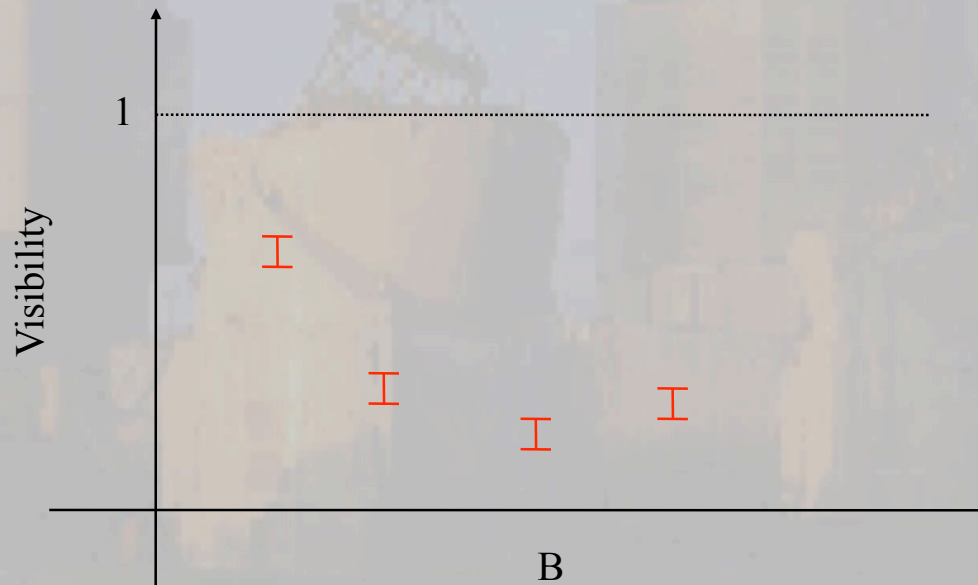


Projected baseline in x dimension (B_x) in m
or V coordinate (in m/λ)

In fact with one visibility measurement with one baseline you are only sampling one spatial frequency component of the visibility amplitude.

Measuring visibilities with an interferometer

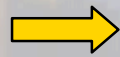
This talk is about what you could do to with that ...



Simple first step: parametric analysis using basic visibility functions.

Model fitting

This talk adresses the basic issues of interpreting visibilities directly



Realistic in the VLTI AMBER and MIDI contexts

Model fitting in the visibility domain is a very attractive complement (alternative) to imaging:

- Domain where measurements are made-> errors easier to recognize
- When (u,v) plane sampling is poor
- Might be better to address some issues such as source variability

OUTLINE

1. Modeling visibilities: principles.
2. Some useful basic functions.
3. Practical issues.
4. Conclusion

Ad-hoc modeling

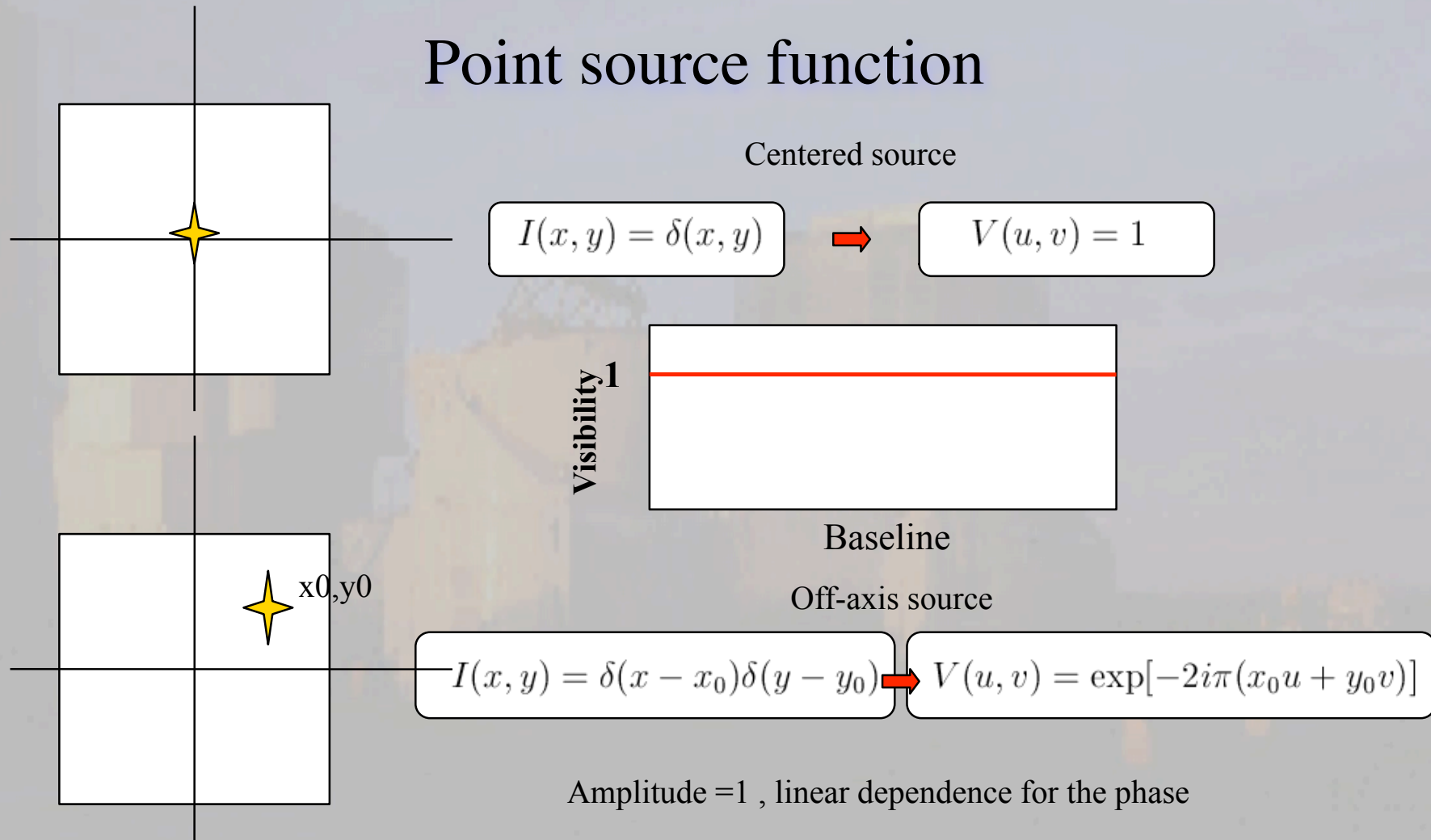
Fourier transform properties
Use of basic intensity distribution functions .

} Important first step
towards modeling with
real physical model

Fourier transform properties:

- 1. Addition** $\text{FT}\{f(x, y) + g(x, y)\} = F(u, v) + G(u, v)$
- 2. Convolution** $\text{FT}\{f(x, y) \times g(x, y)\} = F(u, v) \cdot G(u, v)$
- 3. Shift theorem** $\text{FT}\{f(x - x_0, y - y_0)\} = F(u, v) \exp[2\pi i(ux_0 + vy_0)]$
- 4. Similarity theorem** $\text{FT}\{f(ax, by)\} = \frac{1}{|ab|} F(u/a, v/a)$

Point source function



Gaussian brightness distribution.

Use: Estimate for angular sizes of envelopes-disks etc

$$I(r) = \frac{I_0}{\sqrt{\pi/4 \ln 2} a} \exp(-4 \ln 2 r^2 / a^2)$$



$$V(\rho) = \exp[-(\pi a \rho)^2 / (4 \ln 2)]$$

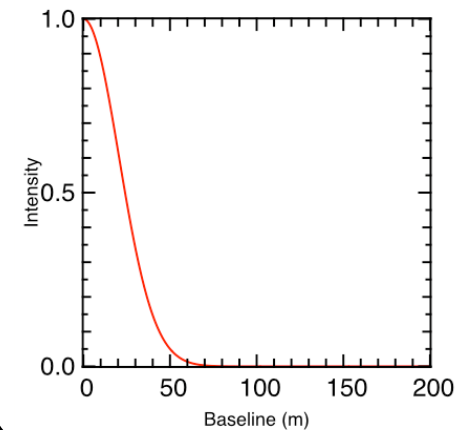
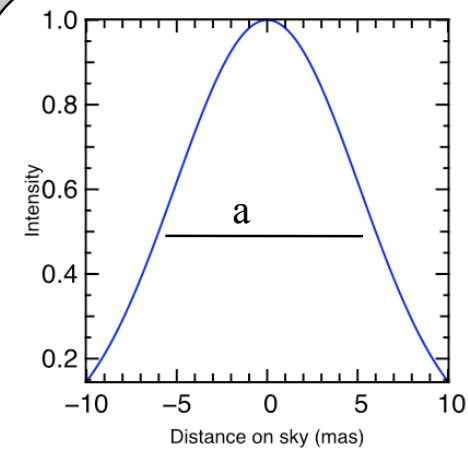
Where a: FWHM intensity, I_0 Peak intensity

with

$$r = \sqrt{x^2 + y^2}$$

with

$$\rho = \sqrt{u^2 + v^2}$$



Uniform disk

Use: approximation for brightness distribution of photospheric disk.

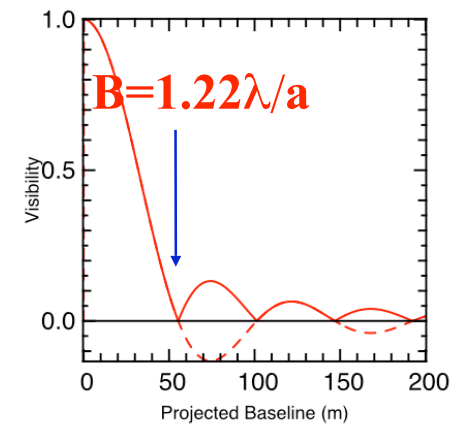
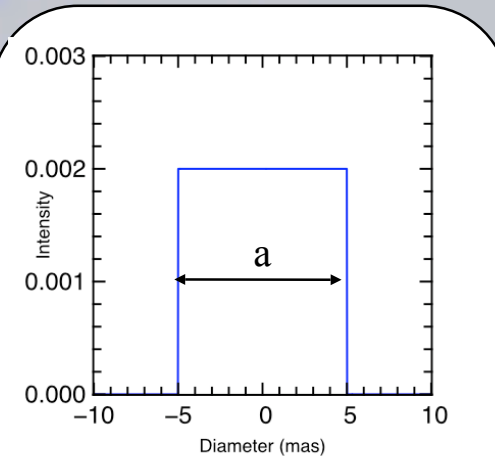
$$\begin{aligned} I(r) &= 4/(\pi a^2), \text{ if } r = \sqrt{x^2 + y^2} \leq a/2 \\ I(r) &= 0 \text{ otherwise} \end{aligned}$$



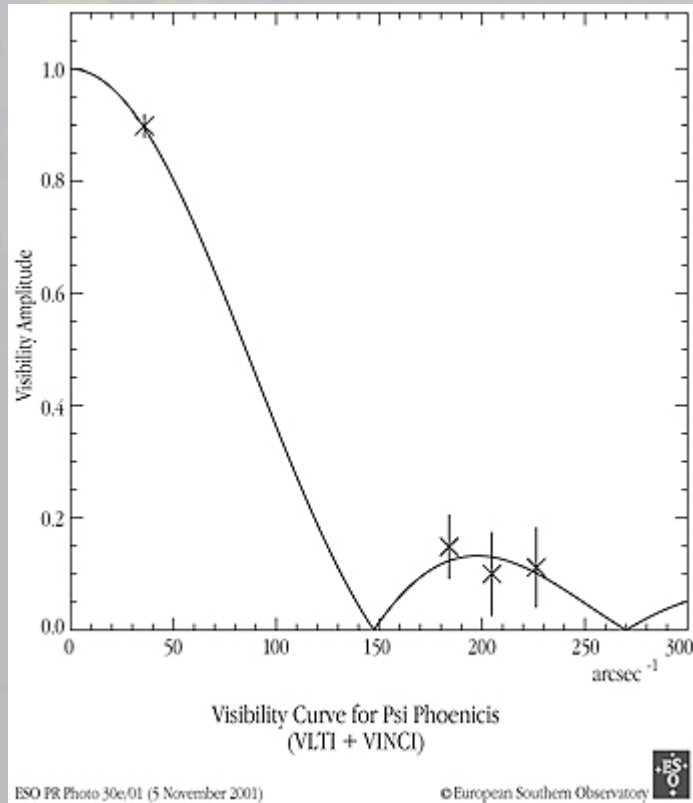
$$F(\rho) = \frac{J_1(\pi a \rho)}{\pi a \rho} \text{ with } \rho = \sqrt{u^2 + v^2}$$

a: diameter

Sophistication of the model $I = f(r)$, limb darkening
Cf Young

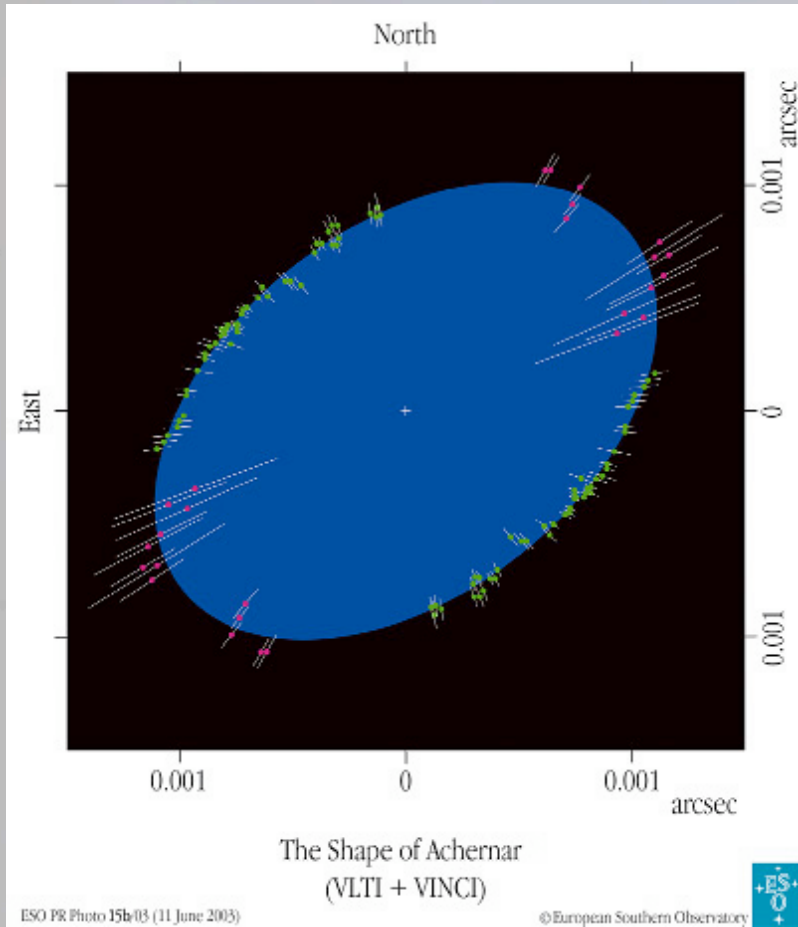


Uniform disk (example 1)



Determination of uniform diameter of Psi Phoenicis with
VLTI/VINCI
Second lobe points are the most constraining

Uniform disk (example 2)



Determination of uniform diameter of Achernar (VLTI/VINCI) at different positions angles shows evidence for flattening due to fast rotation (Dominiciano da Souza et al A&A 2003).

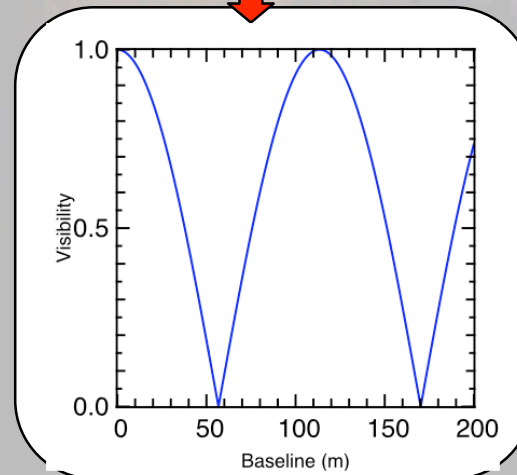
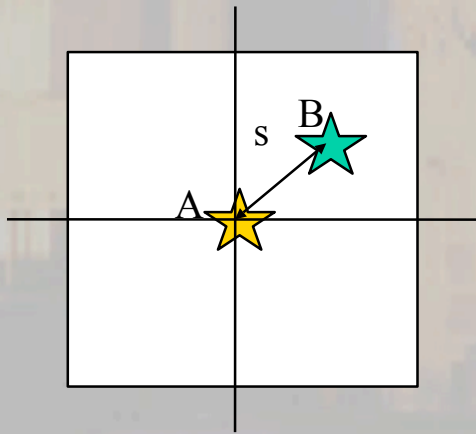
Binary

Unresolved

$$A\delta(x, y) + B\delta(x - sx, y - sy) \text{ with } s = \sqrt{sx^2 + sy^2}$$

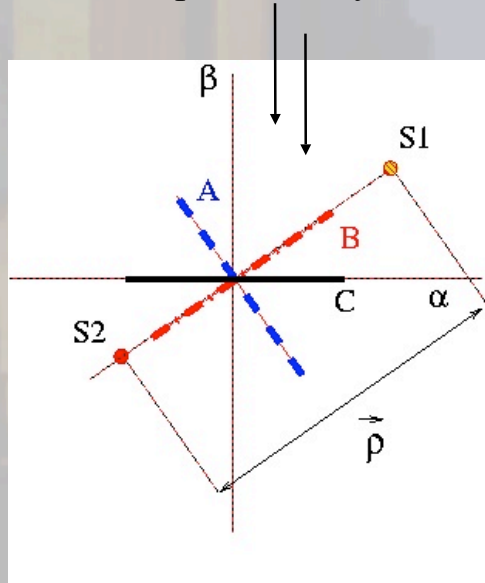
$$V(u, v) = \sqrt{\frac{1+r_{ab}^2+2r_{ab} \cos 2\pi \vec{L}_b \vec{s} / \lambda}{1+r_{ab}^2}}$$

with $r_{ab} = A/B$
with $\vec{L}_b =$ Baseline vector

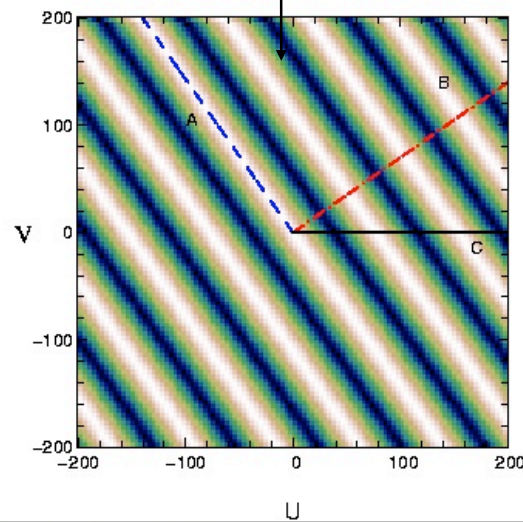


Binary (unresolved)

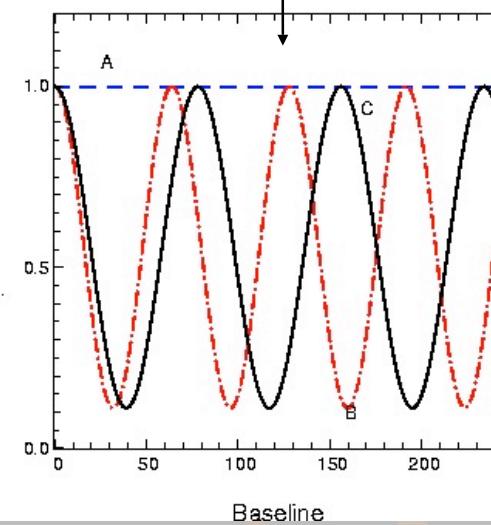
Projection of baseline in the plane of sky



The visibility amplitude squared in (uv) plane

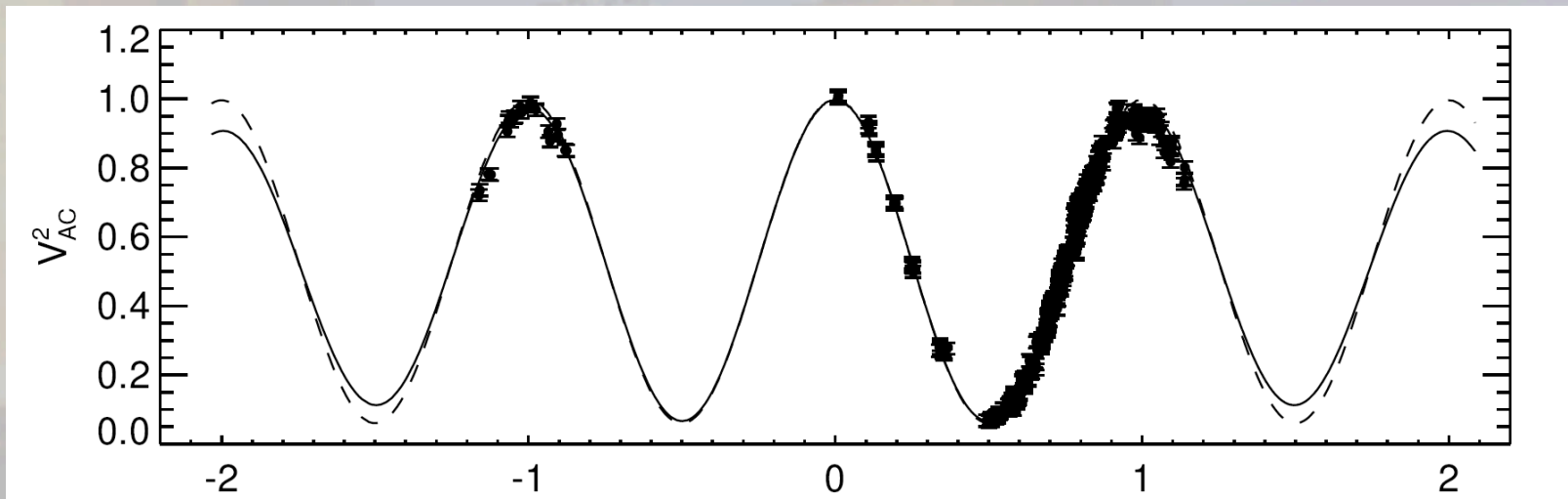


Squared visibility curves for three baselines as a function of baseline length



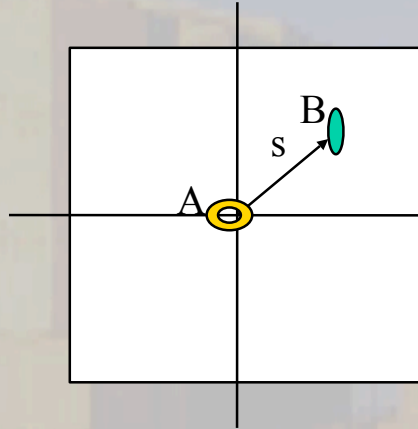
Binary (unresolved)

Binary squared visibility curve as function of hour angle (Ming et al in preparation, observed at IOTA with IONIC)



Resolved bi-structure

Use: Describing any multicomponent structure.



$$V^2(u, v) = \frac{r_{ab}^2 * V_a^2 + V_b^2 + 2r_{ab}|V_a||V_b| \cos(2\pi \vec{L}_b \vec{s} / \lambda)}{(1 + r_{ab}^2)}$$

Where V_a and V_b are respectively the visibility of object A and B at baseline (u, v)

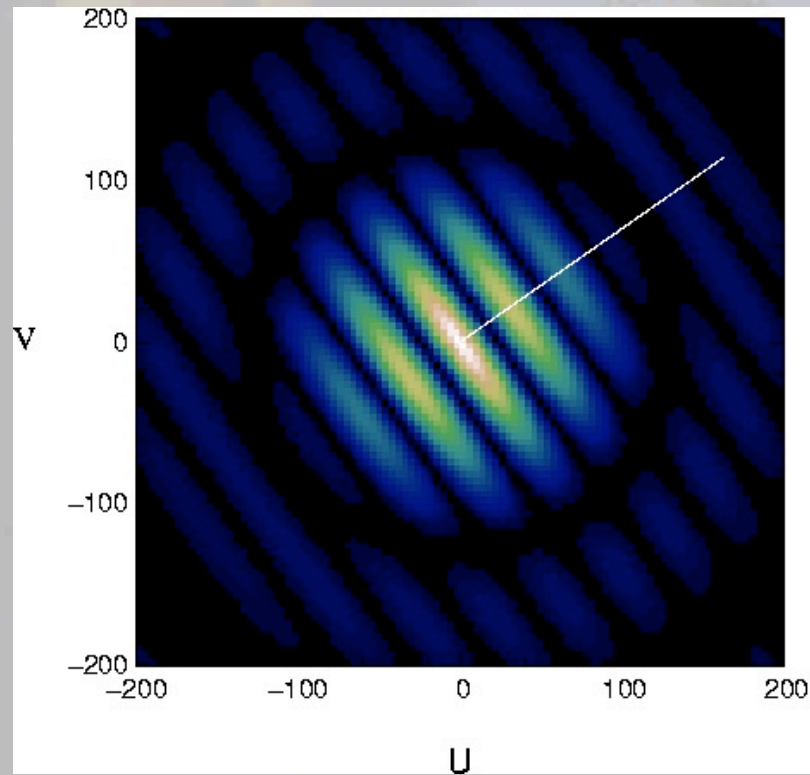
Generalization:

$$V(u, v) = \frac{\sum_{i=1}^k F_i V(u_i, v_i)}{\sum_{i=1}^k F_i}$$

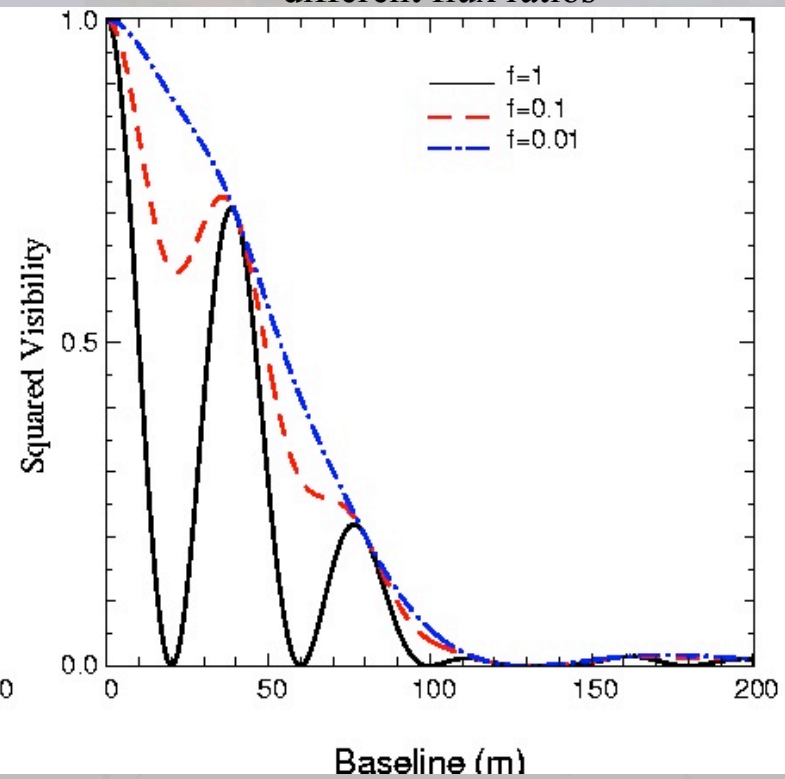
Resolved bi-structure (example)

Binary made of two resolved
photometric disks: $d=3\text{mas}$, PA:
35deg

Squared visibility in (u,v) plane

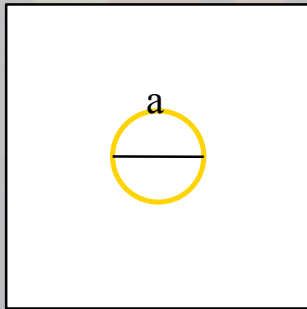


Squared visibility as a function of baseline for
different flux ratios



Unresolved ring & Ellipse

Use: allowing to describe a more complex centro-symmetric structure and compute its visibility
 e.g: an accretion disk made of a finite sum of annuli with different effective temperatures

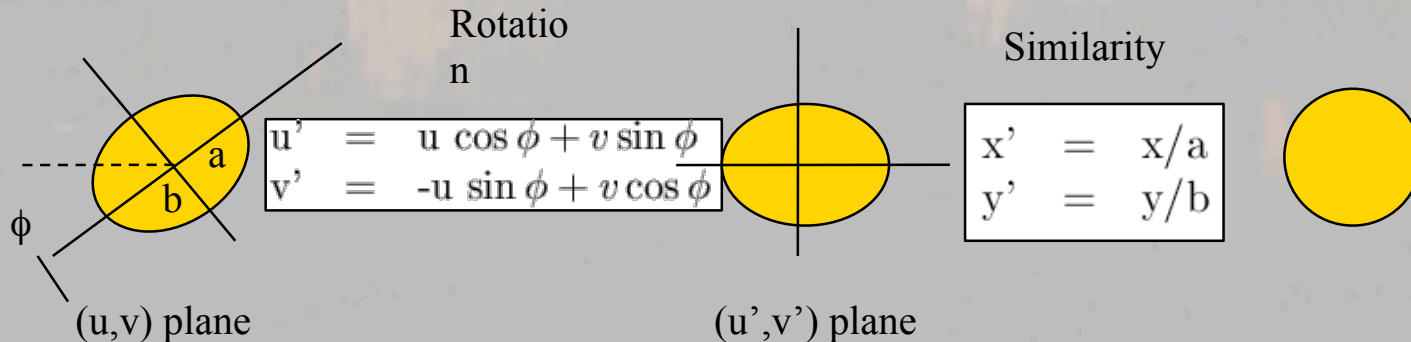


$$I(r) = 1/(\pi a)\delta(r - a/2)$$



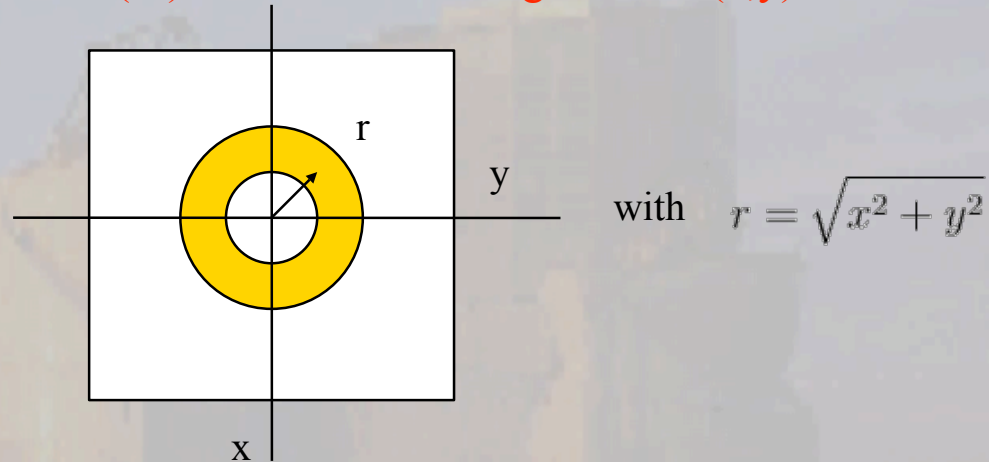
$$V(\rho) = J_0(\pi a \rho)$$

Transformations



Circularly symmetric component

Circularly symmetric component $I(r)$ centered at the origin of the (x,y) coordinate system.



The relationship between brightness distribution and visibility is a Hankel function

$$V(\rho) = 2\pi \int_0^{\infty} I(r) J_0(2\pi r \rho) r dr \quad \text{with} \quad \rho = \sqrt{u^2 + v^2}$$

The modeling process.

Model

Parameters α, β, γ

$$I(x, y)$$

$$V(u, v) = \int_{-\infty}^{\infty} \int_{-\infty}^{\infty} I(x, y) \exp(-2\pi i(xu + yv)) dx dy$$

This talk

- Perfect (u, v) sampling
- Monochromatic

Instrument

Sparse sampling $S(u, v)$

Error $\epsilon(u, v)$

Data & Error

$\{\dots, V(u_i, v_i), \dots\} i = 1..n$


$\{\dots, V'(u_k, v_k), \dots\} k = 1..n$

A minimization process:

$$\chi^2 = f(V(u_i, v_i), V'(u_k, v_k), \epsilon'(u, v))$$

Best

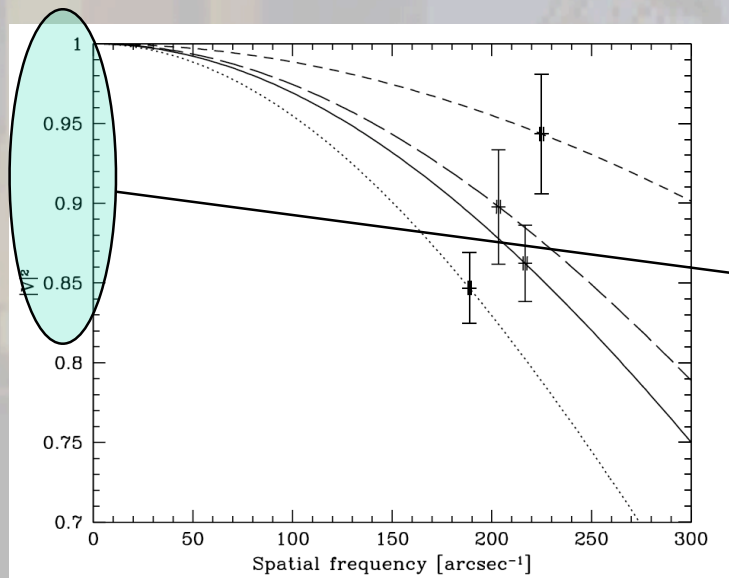
α, β, γ



Pushing the limits

Small diameter estimation

Model fitting is also a deconvolution process: sizes estimates or positional uncertainties can be smaller than the canonical resolution (the “beam” size”): **super resolution**



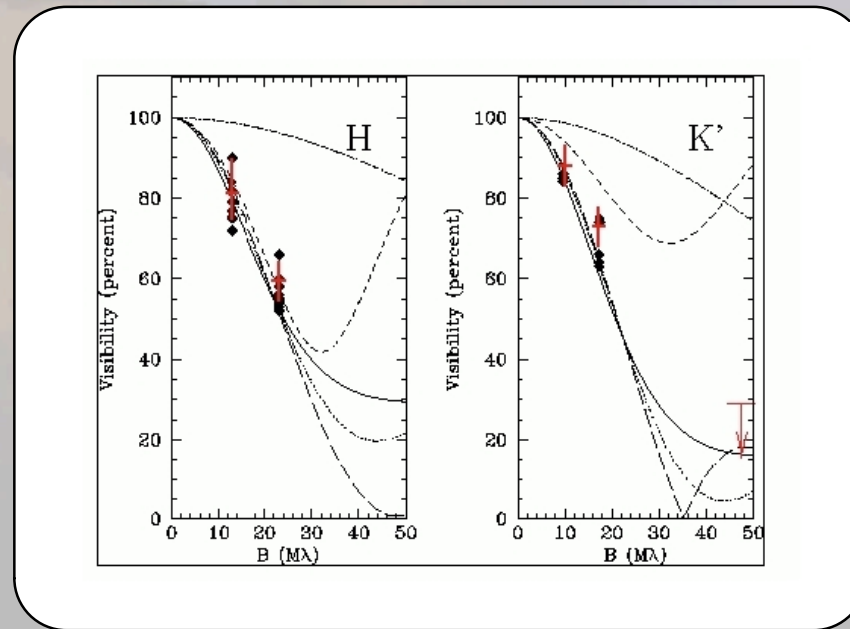
First measurements of M dwarfs stars diameters (Segransan et al, 2003) .

Look how small visibilities are. No need for zero visibility measurements to retrieve diameters

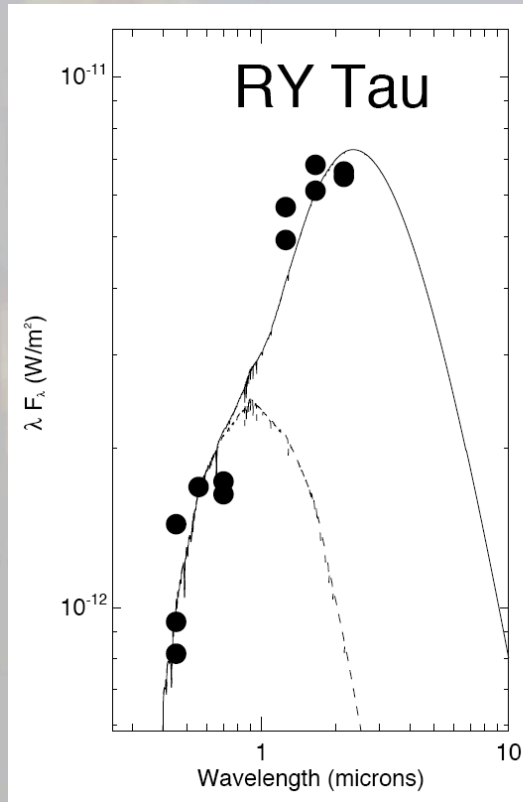
Degeneracy at small baselines

If the object is barely resolved the exact brightness distribution is not crucial - the dependence is quadratic for all the basic functions: visibility accuracy is mandatory

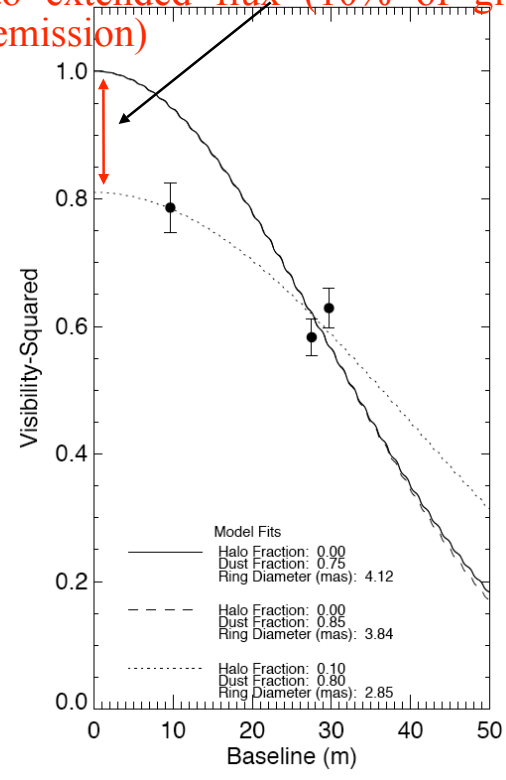
Modelisation of accretion disk emission around young star AB Aur. Both gaussian, uniform disk and ring fit visibilities equally well



Detecting extended emission (Monnier et al ApJ 2006)



Visibility drops rapidly: attributed to extended flux (10% of global emission)



Here a simple model of extended (totally resolved) dust emission + gaussian brings the best fit

Pushing the limits: debris disks by interferometry

(Absil et al 2006)

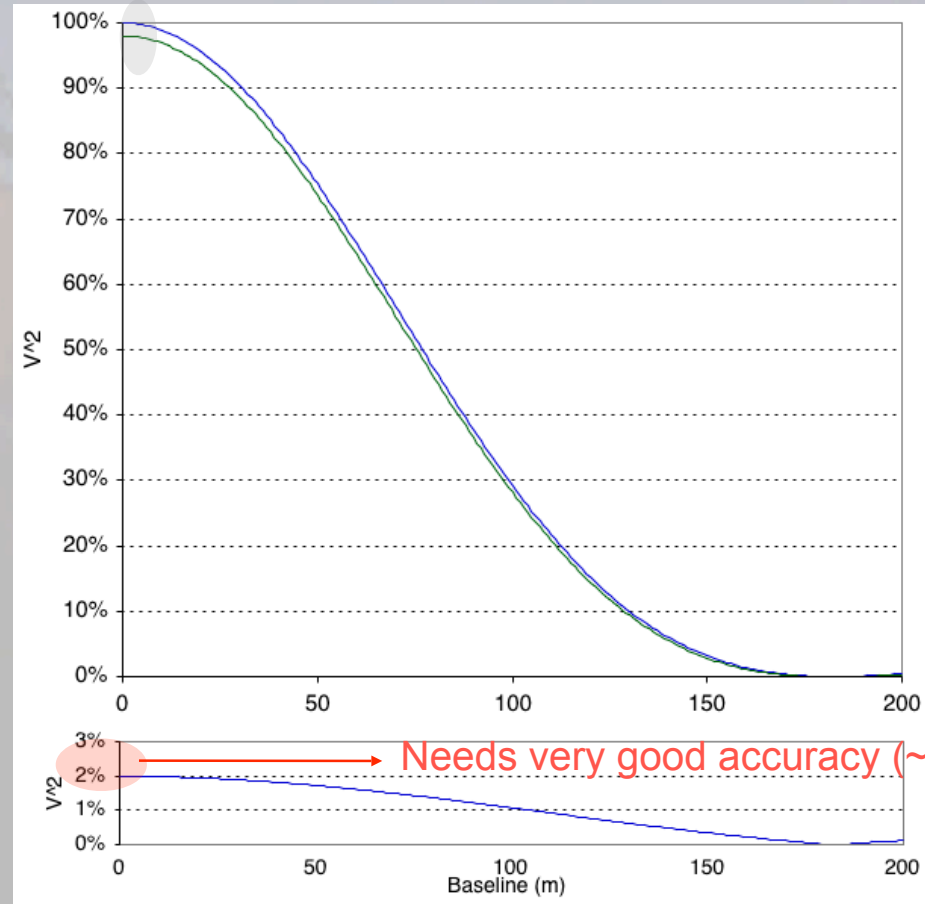
Larger than angular resolution (λ/b) \rightarrow contributes as an incoherent flux

Induces a visibility deficit at all baselines

Best detected at short baselines

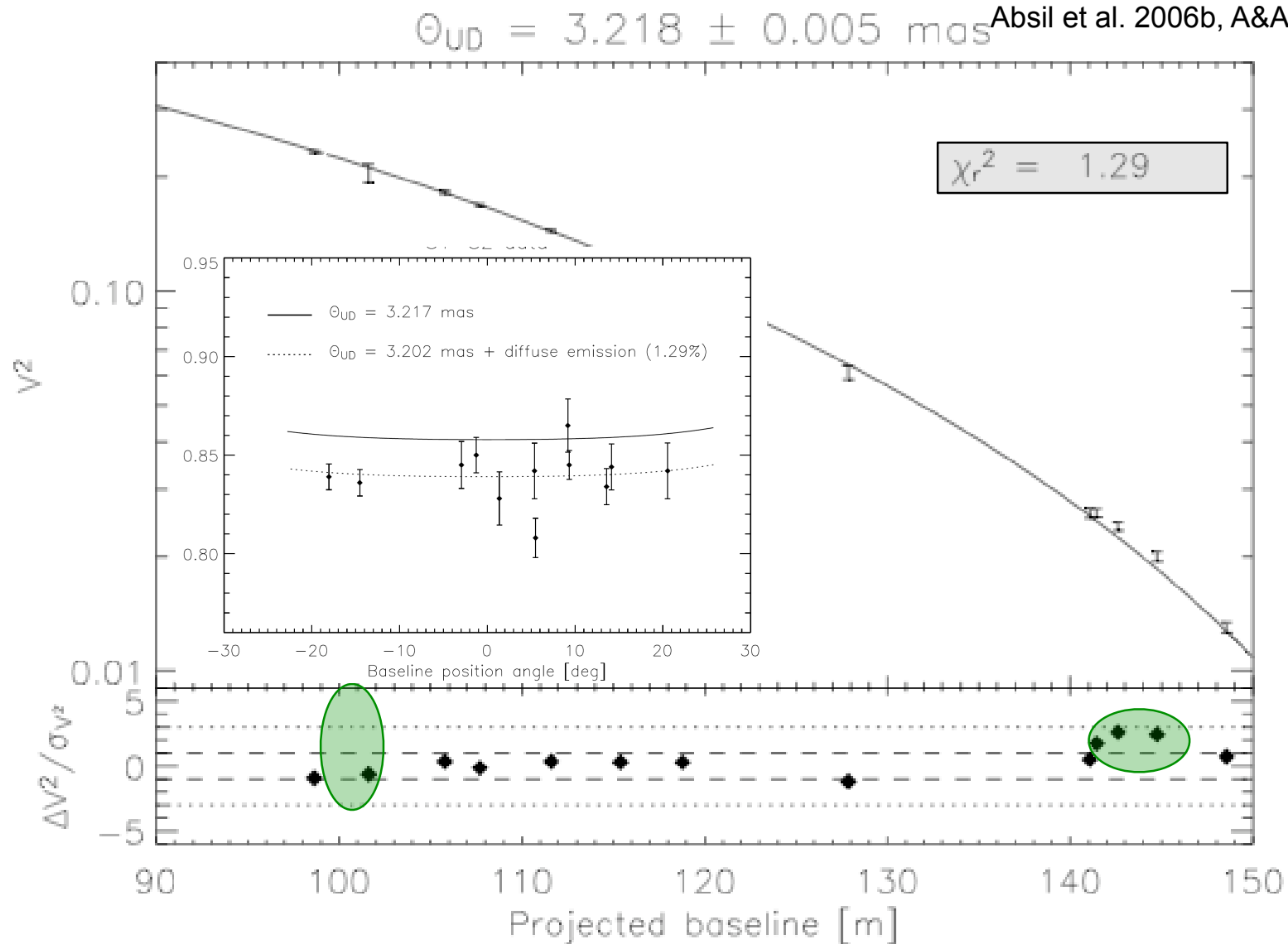
Flux ratio

$$V^2 \approx (1 - 2f) \left(\frac{2J_1(\pi b \theta / \lambda)}{\pi b \theta / \lambda} \right)^2$$



Pushing the limits: debris disks by interferometry

Absil et al. 2006b, A&A



Conclusion

- ✓ Visibility study without imaging can be efficient.
- ✓ The (u,v) coverage strategy is different from imaging. Limited allocated time means limited (u,v) points.
- ✓ Use basic models in order to prepare your observation and determine what is the more constraining configuration.
- ✓ Visibility space is the natural place to understand the errors of the final result.
- ✓ Always start by describing your observations in terms of basic functions. It brings quantitative information useful for further more detailed computations.